Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10574455	NIV ET AL.
Examiner	Art Unit
BENJAMIN P LEE	3641

SEARCHED						
Class	Subclass	Date	Examiner			
89	40.03	10/16/2008	LEE			
89	37.17	10/16/2008	LEE			
89	41.02	10/16/2008	LEE			
89	41.05	10/16/2008	LEE			
89	36.08	10/16/2008	LEE			

SEARCH NOTES				
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INTERFERENCE SEARCH							
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